

产品信息

Contour measuring station MarSurf CD 140 AF

产品特性

MarSurf CD 140 AF - Space-optimized measuring station for production

With the new MarSurf CD 140 AF, Mahr has launched a new contour measuring device onto the market. Its probe system has a measuring range of up to 70 mm, with which the probe tips can be changed quickly and without tools # and all without recalibration.

MarSurf CD 140 AF makes fast and precise measurements possible. Thanks to its flexible workpiece holder, it is particularly easy to handle and impresses with its great versatility.



物品号: 6269054

技术数据

分辨率	20 nm
测量力 (N)	4 mN to 30 mN, software adjustable
测量速度	0.1 mm/s 到 10 mm/s
Positioning speed X-axis min.	0.1 mm/s
positioning speed X-axis max.	200 mm/s
定位速度 (mm/s), X 轴	0.1 - 200 mm/s
测头	Contour tracing system
重量 (毛重)	38 KG
Workpiece weight max.	1.5 kg
其他	machine weight: 35 kg
测量范围 mm	70 mm with probe arm length 350 mm

附件

订单号	标识	产品型号
6710401	V 形块	PP